

On-Board Preventive Maintenance: Analysis of Effectiveness and optimal Duty Period

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Abstract,

To maximize reliability of a spacecraft which performs long-life (over 10-year), deep-space mission (to outer planet), a fault-tolerant environment incorporating automatic on-board preventive maintenance is highly desirable. In this paper, we present an initial model-based study which identifies the key factor for the effectiveness of on-board preventive maintenance and demonstrates the capability of analytic modeling in determining optimal interval between maintenance (duty period).

1 Introduction

Pluto Express is a NASA mission to explore Pluto, the only unsurveyed planet in our solar system. Currently, Jet Propulsion Laboratory is performing studies to achieve the objectives of the mission. Due to the immense distance of Pluto, Pluto Express has very long mission life (12 years) which has created many unprecedented challenges [1]. For example, in order to reduce the flight time, the mass of Pluto Express has to be very low. Consequently, Pluto Express will have very limited power on-board. Furthermore, the reliability of the spacecraft is extremely demanding due to the long mission life. In order to meet these challenging requirements, the Pluto Express Data System employs a dual-string adaptive fault-tolerant architecture, in which two processor strings are able to share workload in a non-redundant manner [2]. Upon failure of one of the processor strings, the surviving string will takeover all the workload. To further enhance mission reliability, the design team has been investigating into the notion of on-board preventive *maintenance*, which can be realized in a cost-effective manner based on the inherent system redundancy (the dual processor

strings that perform spacecraft and scientific functions during encounter time). With on-board preventive maintenance, the two processor strings are scheduled to be on/off duty periodically, in order to reduce the likelihood of system failure due to radiation damage and other reversible aging processes. Moreover, since both the system and application software will be reinitialized upon a string is powered on, switching between strings also results in *software rejuvenation*. The notion of software rejuvenation has been recently proposed aimed at avoiding failures caused by potential error conditions accrued in the operating system environment such as memory leakage, unreleased file locks and data corruption [3]. The implementation of this idea involves deliberately stopping the running program and cleaning its internal state through flushing buffers, garbage collection, reinitializing the internal kernel tables, or "reboot" of a computer. Such preventive maintenance procedures will usually result in appreciable system downtime, however, by exploiting the inherent hardware redundancy, the performance cost for our application could be minimal because 1) normally at least one of the strings will be performing; its duty and, 2) the performance overhead for a string's re-initialization can be masked by starting it before the current, active string gets off duty.

An essential issue in preventive maintenance is to determine the optimal interval between successive maintenance to balance the risk of system failure due to component fatigue/aging against that due to unsuccessful maintenance itself. Accordingly, we have been conducting a tnode-based dependability analysis, aimed at predicting the effectiveness of the on-board preventive maintenance approach and identifying the optimal *duty* period (we will use this term to refer to the interval between successive switching in the remainder of the paper). Due to the deterministic nature of a duty period, the system behavior cannot be directly represented by a Markovian process. However, via a hierarchical decomposition, we are able to construct and solve the analytic models in a relatively straight forward and simple manner. The numerical results reveal the key factor for the effectiveness of on-board preventive maintenance is the switching coverage (the likelihood that switching is performed successfully) and demonstrate the capability of analytic modeling in determining optimal duty period.

Since we emphasize a methodological point of view rather than definitive numerical results based on accurate parameter values at this initial-study stage, the central purpose of this paper is to show how analytic modeling can be employed in guiding the design of on-board preventive maintenance. The remainder of the paper is organized as follows. Section 2 provides more background information about the Pluto Express Data System. Section 3 describes the method for mock construction, followed by Section 4 which discusses the preliminary evaluation results. The concluding section summarizes what we have accomplished and discusses our plan for the subsequent research,

2 Background

Pluto Express has adopted the technologies developed by the New Millennium Deep Space One (NM¹DS1) extensively [4, 5]. The NM¹DS1 has developed an architecture which consists of a RAD-6000 processor multi-chip module (MCM), a local memory MCM, a non-volatile mass memory MCM, and an I/O MCM (see Figure reffig:ds1). The MCMs are

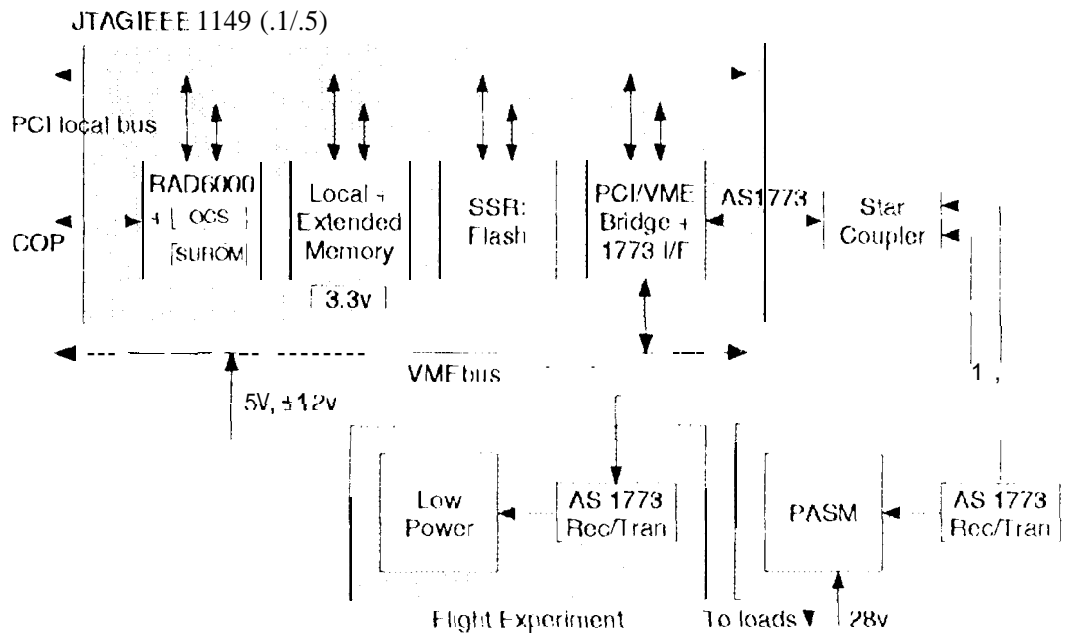


Figure 1 DS1 Architecture

stacked together and are connected by the industrial standard PCI bus via vertical connectors. The Pluto Express Data System has extended this architecture by employing dual DS1 MCM stacks (referred to as processor strings hereafter) to enhance the system reliability. The main feature of its architecture is the I/O cross-strapping, for the dual processor strings. This technique exploits features of the 155311 protocol chips to achieve increased fault protection **without** adding much **wiring complexity** to the data interface (see Figure 2). Each processor string has its own 1553B bus and an additional interface to the 1553B bus of the other string. Further, the system design team propose to turn on only one processor string during the cruise phase, which will not only conserve power but also slow down the strings' aging process. Such a low-power operation is supported by the cross-strapping architecture described above. Clearly, the data interface architecture provides great flexibility to the preventive-maintenance oriented role switching between the strings.

We have conducted initial studies on the effectiveness of on-board preventive maintenance

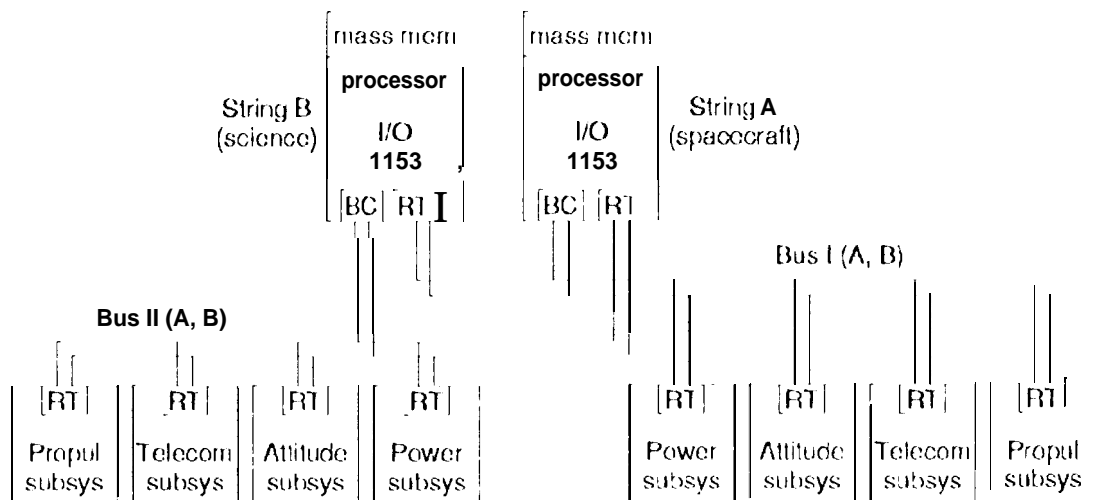


Figure 2: Pluto Express Data System Architecture

and optimal duty period based on two types of assurance regarding the failure behavior of a string. Namely,

- Staged failure process

As assumed by [3], it takes time for a system to age and then eventually crash. Hence, there is an interval after a system enters its duty cycle such that the system is highly robust and very unlikely to fail. However, as the system gets stressed in long run it becomes vulnerable to failure. Assuming the times to vulnerable and failed stages are exponentially distributed, then the staged failure process is a Markov process as shown in Figure 3.

- Weibull distribution

It is a common distribution used in reliability engineering for modeling the effect of “aging” (time-increasing failure rate) and “maturing” (time-decreasing failure rate).

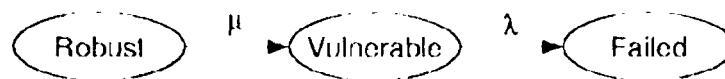


Figure 3: Staged Failure Process

3 Model Construction

A typical research issue on preventive maintenance is to find the optimal interval between successive maintenance which minimizes the cost associated with system downtime due to maintenance and the cost of system failure resulting from an unsuccessful maintenance. Earlier work related to identifying the optimal maintenance policy either used 1) continuous time Markov chain, assuming the interval between successive maintenance is exponentially distributed [3], or 2) Markov regenerative stochastic Petri net (MRSPN), assuming deterministic interval [6]. While the former is unrealistic, the later requires complicated and very time-consuming solution methods. Although Petri-net based modeling tools have been developed to accommodate deterministic transition time, to our best knowledge, they facilitate only steady-state solutions which are not meaningful to our application. On the other hand, the characteristics of the Pluto Express application allow us to employ a model construction method that is relatively simple. That is, we decompose the object system into two layers with respect to its temporal dimension the lower layer represents the success/failure process in terms of duty period while the upper layer represents the mission-level success/failure. The approach is flexible in the sense that it allows us to vary basic assumptions about failure process by modifying only the lower-layer. The solution method is relatively simple because it involves only standard mathematical functions which can be implemented in general-purpose programming languages or using general-purpose mathematical software package such as Mathematica¹. We describe the hierarchical model construction method below.

The staged failure process of the dual-string system can be represented by the state transition diagram shown in Figure 4 (where we assume that the switching process takes a negligible amount of time). Each of the states in the diagram is encoded by two indicators, the first and second indicators represent the status of the first and second strings, respectively. The definitions of the indicators are as follows.

- 1 A string is active and robust.
- 1' A string is active and vulnerable to failure
- 2 A string is in a "rejuvenation" mode.
- o A string is failed.

And the following are the definitions of the transitions

- T_1 From a robust mode to a vulnerable mode

¹Mathematica is a registered trademark of the Wolfram Research.

- T_2 From a vulnerable mode to a failed mode but the other string Lake% over successfully.
- T_3 From a vulnerable mode to a failed mode and the system is unable to recover due to exhaustion of resource or unsuccessful switching.
- T_4 From a robust or vulnerable mode to a “rejuvenation” mode (switching).

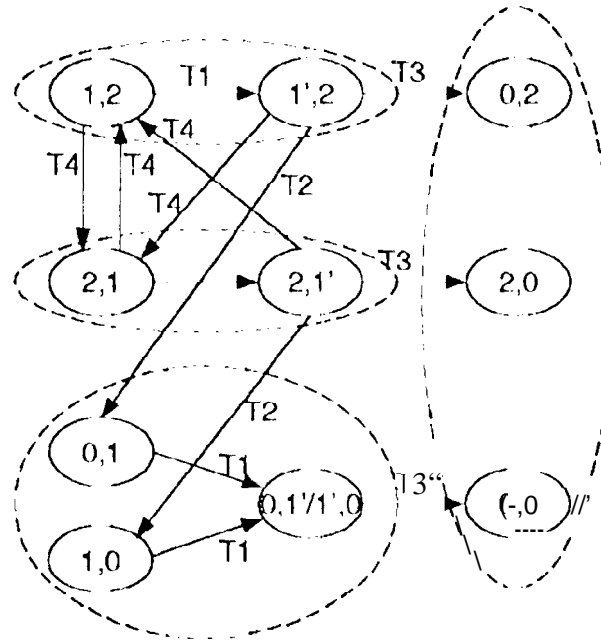


Figure 4: State-Transition Diagram

Note that the corresponding process is not Markovian because the time to transition T_4 is deterministic (scheduled switching), which suggests to us to apply M-RSPN for solution. However, a closer look at the characteristics of the problem leads us to consider an approach that enables us to obtain the desired measures in a more efficient manner. That is, as mentioned in the opening section, hardware redundancy (dual-string and I/O cross-strapping) allows the system downtime due to preventive maintenance be masked such that we are able to employ a stateless approach as described below. As the first step, we convert the state-transition diagram in Figure 4 into a cyclic series-parallel graph that represents system behavior from a duty-period perspective as shown in Figure 5, where each stage corresponds to a cluster of states (as indicated by those dashed ovals in Figure 4). This series-parallel graph reveals that, at a higher level, the system's behavior with respect to strings' duty period is a regenerative renewal process [7]. Accordingly, we can further translate the series-parallel graph into a duty-period oriented timing diagram describing the renewal process as

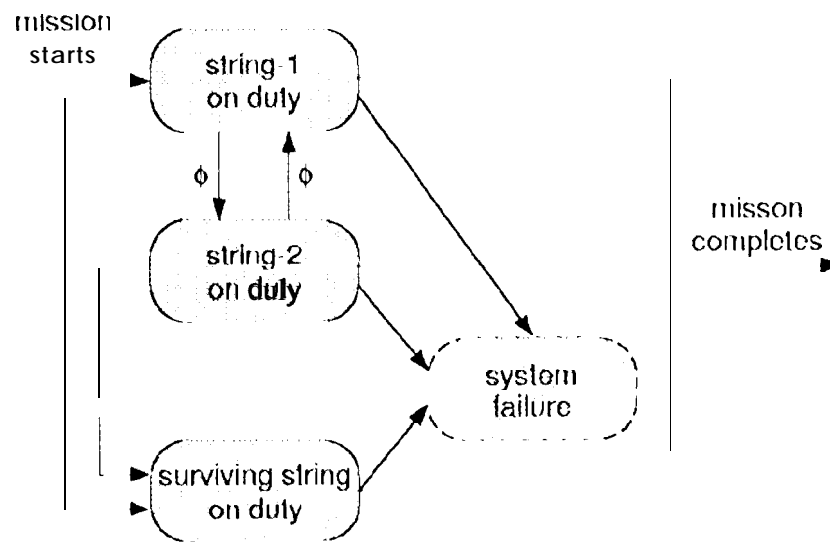


Figure 5: System Behavior

depicted in Figure 6. The notation used in the timing diagram are defined below:

- ϕ The time duration of a string's duty period.
- n The switching frequency in per-mission dimension (thus $(n+1)$ is the number of duty periods).
- k The number of successful duty periods (a string does not fail during its duty period ϕ and the switching process at the end of the duty period is successful).
- x The time for the first string to reach a vulnerable mode.
- y The time for the first string to reach a failed mode.
- z The time for the first string to reach a vulnerable mode.
- u The time for the first string to reach a failed mode.

Thus we can analyze system's success/failure scenarios in terms of the above notation as follows (see Figure 6).

$k = n + 1 \Rightarrow$ The mission succeeds with both strings being operational throughout the mission duration.

$k < n + 1 \wedge z + u > (n + 1 - k)\phi - x - y \rightarrow$ One string fails during the $(k + 1)^{th}$ duty period and the other string remain operational through the remainder of the mission.

$k < n + 1 \wedge x - y \leq (n + 1 - k)\phi - x - y \Rightarrow$ One string fails during the $(k + 1)^{th}$ duty period and the other string subsequently fails before the end of the mission.

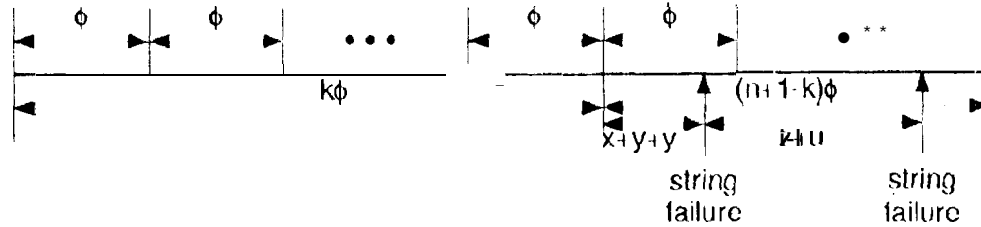


Figure 6: Duty-Period Oriented Timing Diagram

Letting θ denote the duration of a mission ($\theta = 12$ year for the Pluto Express Data System), then ϕ equals to $\theta/(n + 1)$. If further we let $R(\phi)$ denote the mission reliability with a duty period ϕ , it follows that

$$R(\phi) = c^n (1 - P'(\phi))^{n-1} + \sum_{k=0}^{n-1} (c(1 - P'(\phi)))^k c P'_1(\phi, n, k) \quad (1)$$

where c is the coverage of switching process (the likelihood of a successful switching), P' is the probability that a string becomes vulnerable to failure and eventually fails before the end of a duty period, and P'_1 is the conditional probability that a string fails (through a fatigue mode) in the $(k + 1)^{th}$ duty period but the other string remains operational through the remainder of the mission given that the takeover switching process is successful. To solve for P' and P'_1 , the probabilistic measures of the strings' behavior with respect to the time slots illustrated by Figure 6, we can utilize the Markov chain shown in Figure 7 (which is imbedded in the state-transition diagram in Figure 4).

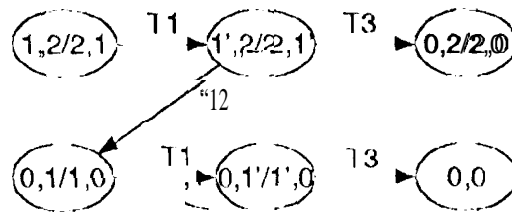


Figure 7: Lower-Layer Model

Although the measures can be obtained using standard transient solution method for continuous time Markov chains, we choose to solve them through convolution which leads to a better understanding of the system behavior when we relate the lower-layer representation (Markov chain) to the duty-period oriented timing diagram. More precisely,

$$F(t) = \int_0^t g(x) \int_0^{t-x} h(y) dy dx \quad (2)$$

and,

$$F_1(t, n, k) = \int_0^t g(x) \int_0^{t-x} h(y) W(x, y, n, k) dy dx \quad (3)$$

where g and h are the density functions (pdfs) of the times for a string to reach its vulnerable and failed states, respectively (see Figure 3); whereas

$$W(x, y, n, k) = \frac{(n+k-1)x^{n+k-1} \int_0^{(n+k-1)t-x-y} g(z) \int_0^{(n+k-1)t-x-y-z} h(u) du dz}{1 - \int_0^x g(z) \int_0^{(n+k-1)t-x-y} h(u) du dz}$$

Therefore, the first term in Equation (1) corresponds to the probability that no failure occurs in any of the $(n+1)$ duty periods and the switching processes are successful throughout the mission, and the second term summarizes the probabilities that a string failure occurs at the $(k+1)^{th}$ duty period but the other string successfully takes over and remains operational through the remainder of the mission. Note that, when $n=0$, Equation (1) is reduced to

$$R(\theta) = (1 - \int_0^{\theta} g(x) dx) c F_1(\theta, 0, 0) = 1 - (F(\theta) - c F_1(\theta, 0, 0))$$

which exactly corresponds to the degenerate case in which on-board preventive maintenance is absent. Accordingly, we use $R(\theta)$ to denote the baseline mission reliability.

To this end, an optimal duty period that maximizes mission reliability can be defined by the following equation,

$$U(R(\phi) | D) = \max_{\phi \in \{0, \theta\}} \{\gamma\} \quad (4)$$

where D is a given set of system conditions (e. g., failure rate, switching coverage, etc.), and γ is a reward function through which mission reliability $R(\phi)$ is formulated (see Equation (1)), 'Thus, optimizing mission reliability for a given set of system conditions D corresponds to maximizing γ with respect to the candidate duty periods with durations in the domain $\{0, \theta\}$.

If we assume that the time to failure has a Weibull distribution (instead of assuming a staged-failure process), the upper-layer model remains the same (thus Equation (1) is still valid) because the mission success criteria are independent of the low-level component failure characterization. However, the lower-layer representation does change such that

$$F(t) = \int_0^t f(x) dx \quad (5)$$

and,

$$F_1(t) = \int_0^t f(x) V(x, n, k) dx \quad (6)$$

where f is the pdf of the time to failure, that is,

$$f(t) = \alpha \lambda (\lambda t)^{\alpha-1} e^{-(\lambda t)^\alpha}$$

and

$$V(x, n, k) = 1 - \int_0^{(n+1-k)t^x} f(y) dy$$

4 Discussion

Applying the models described in the previous section, the effectiveness of on-board preventive maintenance is evaluated with respect to mission reliability gain from preventive maintenance and optimal duty period is also studied. As the first step, we study mission reliability under the assumption of staged-failure process. Figures 8, 9 and 10 depict mission reliability $R(\phi)$ as a function of switching frequency n for different system parameters ($\phi = \theta/(n-1)$, μ is the rate for a string going from its robust state to vulnerable state, λ is the failure rate² and $R(\theta)$ is the corresponding baseline mission reliability). We observe the following (for all three cases, the likelihood of an unsuccessful switching $(1-c)$ is set to 10^{-8}):

- When $\mu = 0.001$ and $\lambda = 0.0001$, preventive maintenance can increase mission reliability from 0.999952 to the 0.999997 range (about one order); and the optimal duty period is 6.2 weeks ($n = 100$).
- When failure rate λ is doubled, preventive maintenance can increase mission reliability from 0.999812 to the 0.999995 range (about two orders); and the optimal duty period is 3.1 weeks ($n = 200$).
- When failure rate λ is tripled, preventive maintenance can increase mission reliability from 0.999587 to the 0.999993 range (about two orders); and the optimal duty period is 2.1 weeks ($n = 300$).

The results demonstrate that the on-board maintenance is indeed effective with respect to mission reliability improvement given that the switching coverage c is sufficiently high (equivalently speaking, the uncovered $(1-c)$ is sufficiently low). Further, the curves reveal the influence of failure rate on optimal duty period. That is, the higher the failure rate, the shorter the duty period should be. This is a reasonable result because a less reliable system in general requires more frequent maintenance.

²Both μ and λ have per-week dimensions.

Figure 11 displays the results of an evaluation in which we assume that the failure process of a string is characterized by a Weibull distribution. The results are consistent with those from the analyses based on staged-failure assumption. From this curve, we see an improvement of mission-reliability about three orders (increased from 0.997213 to the 0.999997 range) and the optimal duty period is 4.2 weeks ($n = 150$).

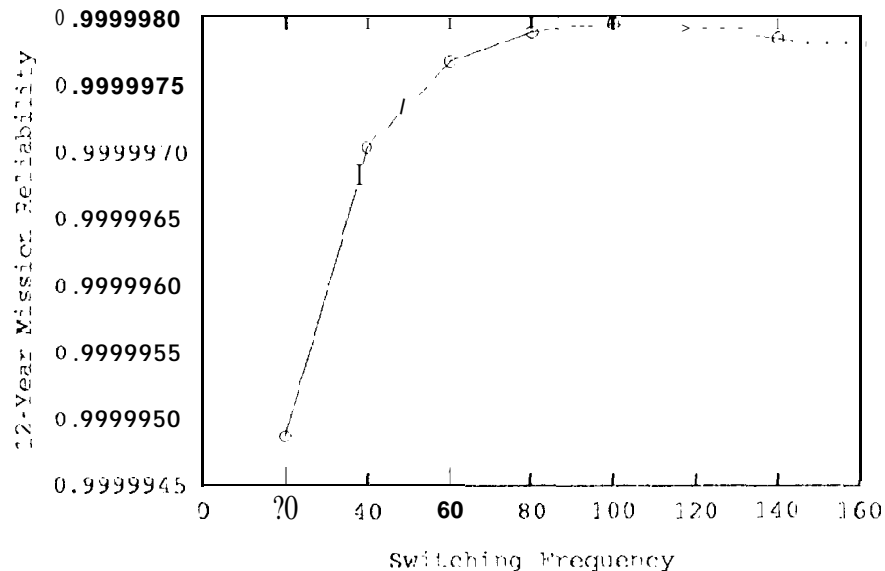


Figure 8: Optimal Switching Frequency ($\mu = 0.001, \lambda = 0.0001, R(\theta) = 0.999952$)

We have also conducted analyses for the effect of the likelihood of an unsuccessful switching ($1 - c$) on mission reliability gain from preventive maintenance. Tables 1 and 2 display the numerical results (based on the staged-failure assumption). Except $(1 - c)$ is kept as a variable, parameter values used for the analyses shown in Tables 1 and 2 are the same as those used for the analyses illustrated by Figures 8 and 10, respectively. From the tables, we see both reliability gain and optimal duty period are sensitive to $(1 - c)$. Specifically, the tables show the following:

1. A lower uncovrage ($1 - c$) permits a shorter duty period (more frequent switching) and leads to greater reliability gain, and vice versa; it is interesting to note that for the case where $\lambda = 0.0001$, the numerical results suggest that it is better to avoid switching if the uncovrage ($1 - c$) equals to 105 or higher.
2. Reliability gain from preventive maintenance is more significant for a system with a higher failure rate (λ) only if the switching uncovrage is sufficiently low.

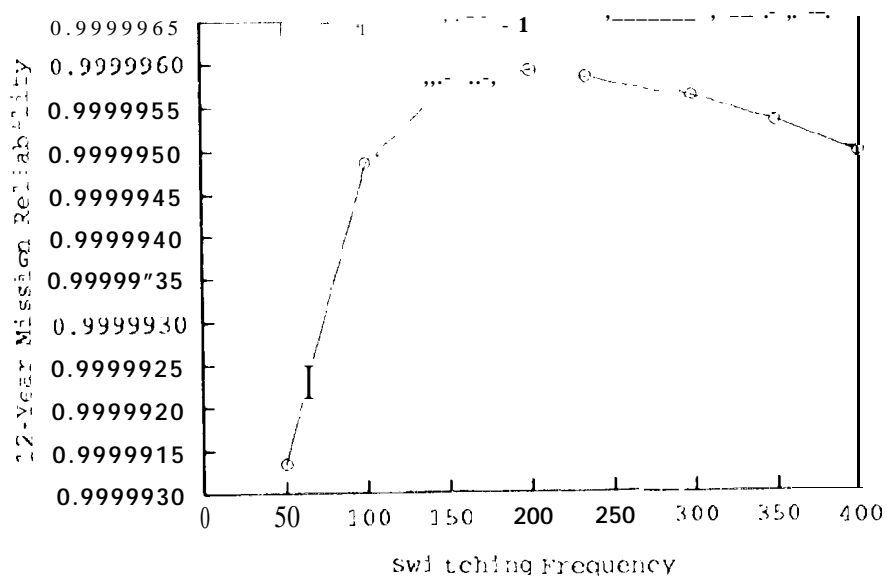


Figure 9: Optimal Switching Frequency ($\mu = 0.001, \lambda = 0.0002, R(\theta) = 0.9998$)

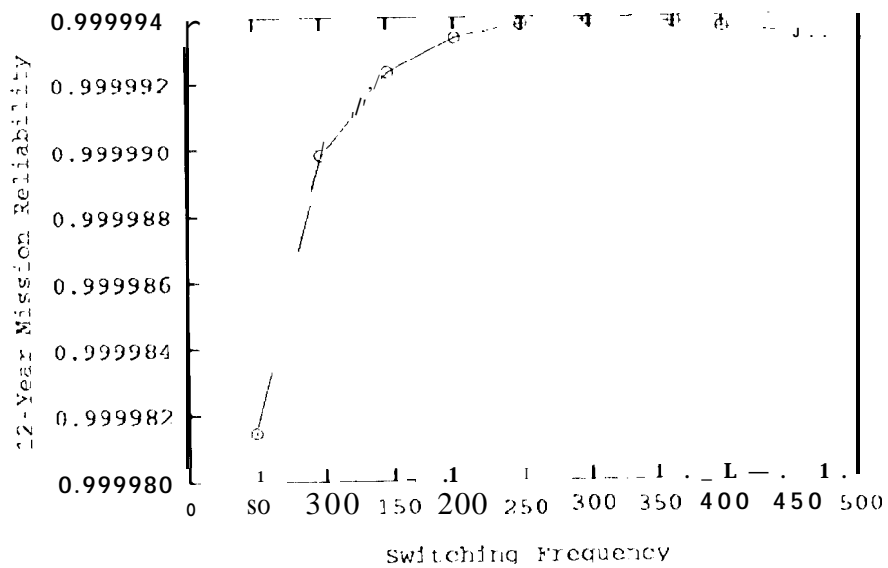


Figure 10: Optimal Switching Frequency ($\mu = 0.001, \lambda = 0.0003, R(\theta) = 0.999587$)

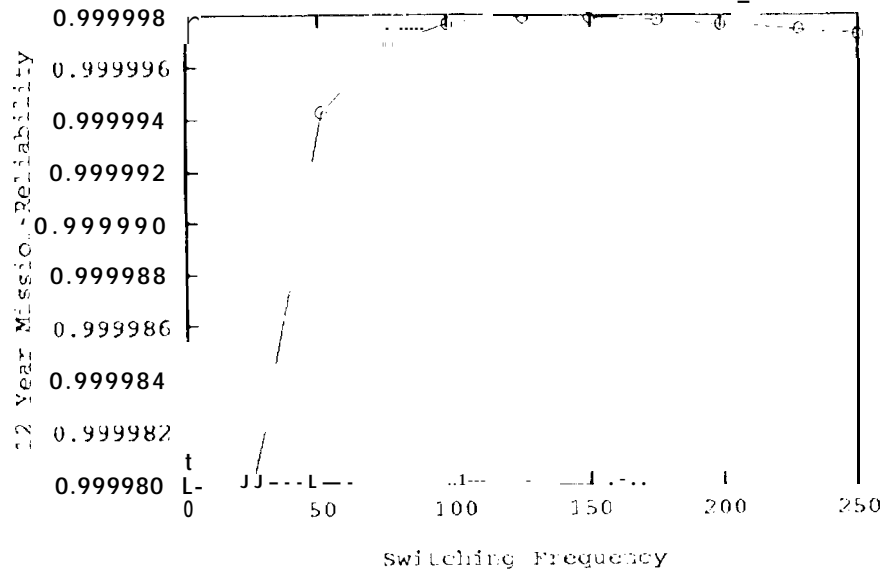


Figure 11: Optimal Switching Frequency ($\alpha = 3.0, \lambda = 0.001, R(\theta) = 0.997213$)

Table 1: Influence of Switch Coverage on $R(\phi_{\text{optimal}})$ and ϕ_{optimal} ($\lambda = 0.0001$)

$(1 - c)$	$R(\theta)$	$R(\phi_{\text{optimal}})$	ϕ_{optimal}	n_{optimal}
10^{-4}	0.999952	0.999952	624.0	0
10^{-5}	0.999952	0.999952	624.0	0
10^{-6}	0.999952	0.999975	29.7	20
10^{-7}	0.999952	0.999993	15.2	40
10^{-8}	0.999952	0.999997	6.2	100
10^{-9}	0.999952	0.999999	1.9	320

Table 2: Influence of Switch Coverage on $R(\phi_{\text{optimal}})$ and ϕ_{optimal} ($\lambda = 0.0003$)

$(1 - c)$	$R(\theta)$	$R(\phi_{\text{optimal}})$	ϕ_{optimal}	n_{optimal}
10^{-4}	0.999587	0.999587	624.0	0
10^{-5}	0.999587	0.999757	29.7	20
10^{-6}	0.999587	0.999938	15.2	40
10^{-7}	0.999587	0.999981	6.2	100
10^{-8}	0.999587	0.999994	2.1	300
10^{-9}	0.999587	0.999998	0.65	960

5 Conclusion and Future Work

We have accomplished the initial investigation into on-board preventive maintenance for the Pluto Express Data System. The results shown in this paper are meaningful for two reasons:

1. They illustrate that it is indeed feasible to apply analytic techniques in predicting effectiveness of and optimal duty period for on-board preventive maintenance for long-life spacecraft applications; moreover, via hierarchical model decomposition, system behavior involving deterministic transition time can be represented and evaluated in a rather simple manner.
2. They provide interesting insight regarding the effect of system failure characteristics on the effectiveness of preventive maintenance and optimal duty period. Specifically, the quantitative results reveal that switching coverage (the likelihood of a successful switching) plays a critical role: for reliability gain from preventive maintenance.

Currently, we are in the process of elaborating the models such that some initial assumptions can be relaxed. In particular, the resulting model will

1. Allow re-initialization time during the power-on of a string to be appreciable; although by taking advantage of inherent system redundancy, re-initialization time can overlap with the duty period of the active string such that the performance overhead and its impact on the effectiveness of string switching will be minimal, it is important to study a design issue - the effect of string re-initialization time on optimal duty period.
2. Accommodate both permanent and transient failures incurred during the power-on of a string (currently, only permanent failures are taken into account via the uncovered $(1 - c)$). Accordingly, the effectiveness of power-cycling for recovery from a transient failure will be investigated.

6 Acknowledgments

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